INFORMATION

PRODUCT No.: Q22FA1280012500

MODEL: FA-128

INFO. No.: A14-385-3A

DATE: Jul. 1. 2014

SEIKO EPSON CORPORATION

8548 Naka-minowa Minowa-machi Kamiina-gun Nagano-ken 399-4696 Japan

INTRODUCTION

- 1. The contents is subject to change without notice. Please exchange the specification sheets regarding the product's warranty.
- 2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
- 3. We have prepared this sheet as carefully as possible. If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

This product is compliant with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes.

Making available such products and technology to any third party who may use such product s or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

Product No. / Model

The product No. of this crystal unit is Q22FA1280012500. The model is FA-128.

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[1] Absolute maximum ratings

| No. | Parameter | Rating value | Note |
|-----|---------------------|-------------------|---|
| 1 | Storage temperature | -40 °C to +125 °C | Suppose to be within CI std. at +25 °C ± 3 °C |

[2] Operating range

| | _ | Symbol | Value | | | |
|-----|-----------------------|--------|--------|------|--------|--|
| No. | No. Parameter | | Min. | Тур. | Max. | |
| 1 | Operating temperature | T_use | -20 °C | | +75 °C | |
| 2 | Drive level | DL | 10 μW | _ | 100 μW | |

[3] Electrical characteristics

| No. | Parameter | Symbol | Standard | Conditions |
|-----|--|----------------|------------------------------|--|
| 1 | Nominal frequency | fo | 24 MHz | Fundamental |
| 2 | Frequency tolerance | f_tol | $\pm 30 \times 10^{-6}$ | CL= 6 pF T_use = +25 °C±3 °C Drive level : 100 μW Not include aging |
| 3 | Motional resistance | R1 | 80 Ω Max. | π circuit JIS C6701 Drive level : 100 μW T_use= -20 °C to +75 °C |
| 4 | Shunt capacitance | C ₀ | 3.0 pF Max. | |
| 5 | Frequency versus temperature characteristics | f_tem | $\pm 30 \times 10^{-6}$ | T_use = -20 °C to +75 °C (Ref. at +25 °C±3 °C) Drive level : 100 μW |
| 6 | Isolation resistance | IR | 500 MΩ Min. | DC 100V × 60 sec. Between each terminals |
| 7 | Aging | f_age | $\pm 1 \times 10^{-6}$ /year | T_use = +25 °C±3 °C Drive level : 100 μW |

[4] Environmental and mechanical characteristics

Item No.3 to No.6 shall be tested after following pre conditioning.

Pre conditioning: Test crystal must be leaving in room temperature for 24 h after reflow \times 3.

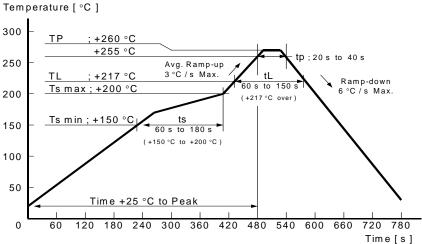
(The company evaluation condition: We evaluate it by the following examination item and examination condition.)

| Ì | 1 1 | Value *1 *2 | Test Carditions |
|-----|------------------------------|-----------------------------------|--|
| No. | Item | $\Delta f / f [1 \times 10^{-6}]$ | Test Conditions |
| 1 | Drop | *3 ±2 | 150 g dummy Jig (SE Standard) drop |
| | | | from 1500 mm height on the Concrete 6 |
| | | | directions 10 times |
| 2 | Vibration | *3 ±2 | 10 Hz to 55 Hz amplitude 0.75 mm |
| | | | 55 Hz to 500 Hz acceleration 98 m/s ² |
| | | | $10 \text{ Hz} \rightarrow 500 \text{ Hz} \rightarrow 10 \text{ Hz} 15 \text{ min./cycle}$ |
| | | | 6 h (2 hours, 3 directions) |
| 3 | High temperature storage | *3 ±2 | +85 °C × 1 000 h |
| 4 | Low temperature storage | *3 <u>+2</u> | -40 °C × 1 000 h |
| 5 | Temperature cycle | *3 ±2 | -40 °C ↔ +85 °C |
| | | | 30 minutes at each temp. 100 cycle |
| 6 | Temperature humidity | *3 ±2 | +85 °C × 85 %RH × 1 000 h |
| | storage | | |
| 7 | Resistance to soldering heat | ±2 | For convention reflow soldering furnace |
| | | | (3 times) |
| 8 | Substrate bending | No peeling-off at a soldered | Bend width reaches 3 mm and hold for |
| | | part | $5 \text{ s} \pm 1 \text{ s} \times 1 \text{ time Ref. IEC } 60068-2-21$ |
| 9 | Shear | No peeling-off at a soldered | 10 N press for 10 s \pm 1 s |
| | | part | Ref. IEC 60068-2-21 |
| 10 | Pull – off | No peeling-off at a soldered | 10 N press for $10 \text{ s} \pm 1 \text{ s}$ |
| | | part | Ref. IEC 60068-2-21 |
| 11 | Solder ability | Terminals must be 95 % | Dip termination into solder bath at |
| | | covered | $+235$ °C \pm 10 °C for 5 s |
| | | With fresh solder. | (Using Rosin Flux) |

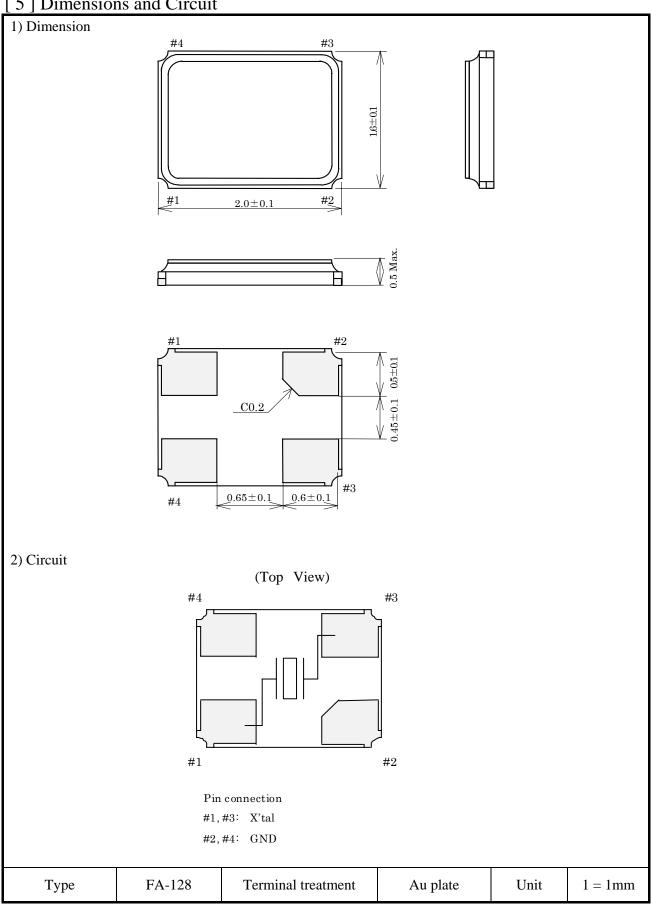
< Notes >

- 1. *1 each test done independently.
- 2. *2 measuring 2 h to 24 h later leaving in room temperature after each test.
- 3. *3 Item No.1 to No.6 shall be tested after following pre conditioning.
- 4. Item No.1 to No.11 resistance at before above tests should be less than ± 20 % or less than ± 10 Ω .
- 5. Pre conditioning: Test crystal must be leaving in room temperature for 24h after reflow \times 3.

Reflow condition (follow to IPC / JEDEC J-STD-020C)



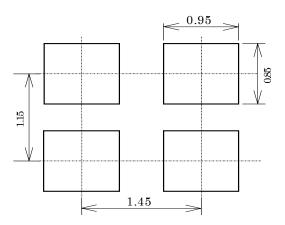
[5] Dimensions and Circuit



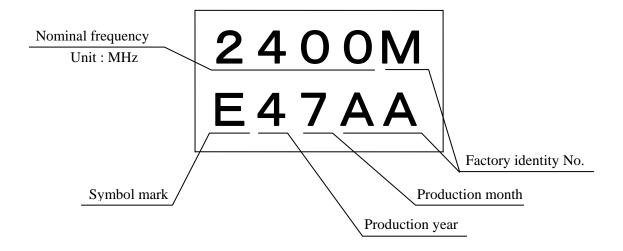
[6] Recommended soldering pattern and Marking layout

1)Recommended soldering pattern

Unit: mm



2) Marking layout



Production month

| January | February | October | November | December |
|---------|----------|-------------|----------|----------|
| 1 | 2 | X | Y | Z |

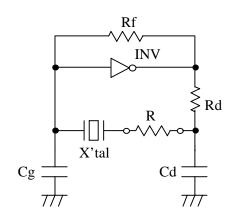
- Nominal frequency is only one example.
- Nominal frequency omits the figure below the second place of decimals. ex) 24 MHz [2400]
- The above marking layout shows only marking contents and their approximate position and it is not for font, size and exact position.

Type : FA-128 Unit : 1 = 1mm

[7] Notes

- 1. Max three (3) times re-flow is allowed. Its recommended to manually solder when not enough/no solder detected.(Using soldering iron at +350 °C × within 5 seconds)
- 2. Patterning on a board should follow our company recommended pattern.
- 3. Applying excessive excitation force to the crystal unit may cause deterioration damage.
- 4. Start up time of oscillation may be increased or no oscillation may occur unless adequate negative resistance is allocated in the oscillation circuit In order to avoid this, please provide enough negative resistance to the circuit design.

How to check the negative resistance



- (1) Connect the resister(R) to the circuit in series with the crystal unit.
- (2) Adjust R so that oscillation can start (or stop).
- (3) Measure R when oscillation just start (or stop) in above (2).
- (4) Get the negative resistance -R=R+CI value.
- (5) Recommended -R $[-R]>CI \times 5$
- 5. It is recommended to do patterning to the oscillator as short as possible. Abnormal oscillation may happened if the line is too long.
- 6. To avoid malfunction, no pattern across or near the crystal unit is allowed.
- 7. Few data or readings taken at user side may be different from our company's data. Confirmation of the different value is necessary before application.
- 8. Too much exciting shock or vibration may cause deterioration on damage.

 The product may damage depends on the condition such as a shock in assembly machinery.

 Please check your process condition in advance to minimize and maintain the shock level.
- 9. This product may be affected to ultrasonic cleaning. It is depends on the cleaning conditions (Cleaning machine type/power/time/content/position etc.). The warranty will not cover any damage due to this type of usage. Check conditions prior to use.
- 10. Condensation may occur when used/stored under high humidity condition. Please take precautions to prevent condensation.
- 11. Please refer to packing specification for the storage method and packing standard.

TAPING SPECIFICATION

1. APPLICATION

This document is applicable to FA-128

2. CONTENTS

| Item No. | Item | Page |
|----------|----------------------|--------|
| [1] | Taping specification | 1 to 2 |
| [2] | Inner carton | 3 |
| [3] | Shipping carton | 3 |
| [4] | Marking | |
| [5] | Quantity | 4 |
| [6] | Storage environment | 4 |
| [7] | Handling | |

[1] Taping specification

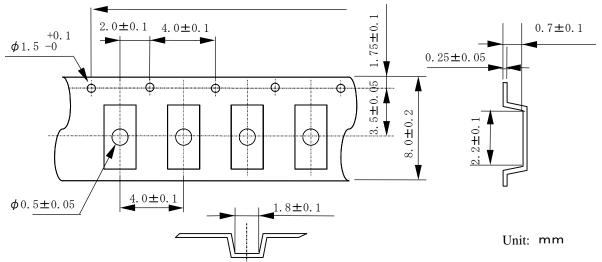
Subject to EIA-481 & IEC-60286

(1) Tape dimensions TE0804L

Material of the Carrier Tape: PS

Material of the Top Tape : PET+PE

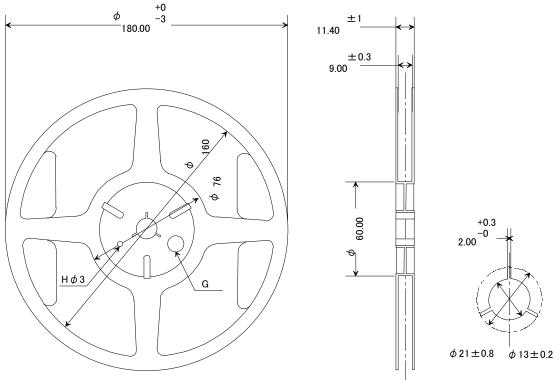
 $10P: 40\pm 0.15$



(2) Reel dimensions

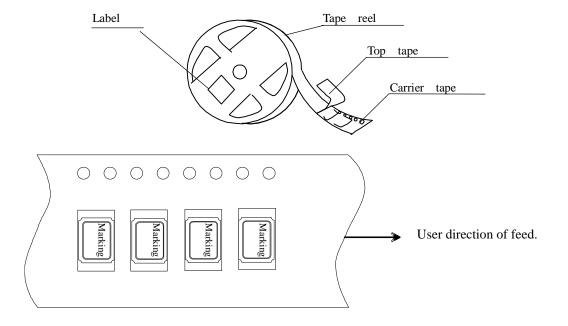
(a) Center material : PS

(b) Material of the Reel : PS

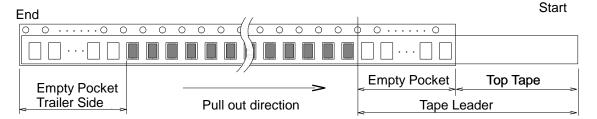


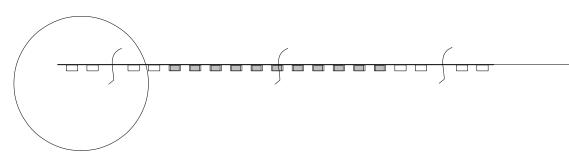
(3) Packing

(a) Tape & Reel



(b) Start & End Point





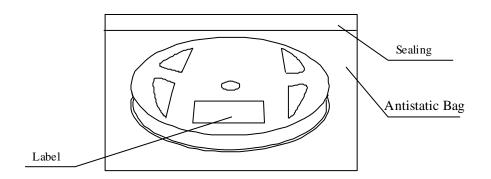
| It | Empty Space | |
|-----------------------|--------------|---------------|
| Tape Leader Top Tape | | Min. 1 000 mm |
| | Carrier Tape | Min. 100 mm |
| Tape Trailer Top Tape | | Min. 0 mm |
| | Carrier Tape | Min. 160 mm |

(4) Peel force of the cover tape

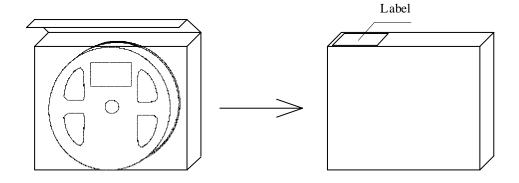
- \bigcirc angle : cover tape during peel off and the direction of unreeling shall be 165° to 180°.
- ② peel speed: 300 mm / min.
- 3 strength : 0.1 to 1 N.

[2] Inner Carton

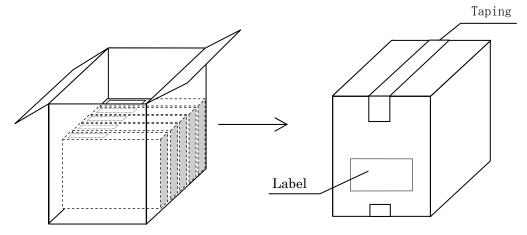
a) Packing to antistatic bag



b) Packing to inner carton



[3] Shipping Carton



[4] Marking

- (1) Reel marking
 - Reel marking shall consist of:
 - 1) Parts name
 - 2) Quantity
 - 3) Manufacturing Date or symbol
 - 4) Manufacturer's Date or symbol
 - 5) Others (if necessary)
- (2) Inner carton marking
 - Same as Reel marking.
- (3) Shipping carton marking
 - Shipping carton marking shall consist of :
 - 1) Parts name
 - 2) Quantity

[5] Quantity

• 3 000 pcs./reel

[6] Storage environment

- (1) Before open the packing, we recommend to keep less than +30 °C and 85 %RH of Humidity, and to use it less than 6 months after delivery.
- (2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 6 month. No need dry air before soldering work if it is less than temperature +30 °C, 85 humidity %RH.
- (3) Not to expose the sun.
- (4) Not to storage with some erosive chemicals.
- (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

[7] Handling

To handle with care to prevent the damage of tape, reel and products.

SMD TYPE AT STRIP CRYSTAL: FA-128

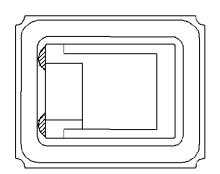
12.09.26

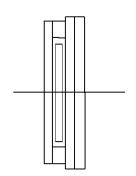
| Manufact | turing | process shart | No. | Section | Standard | Inspection, Control items | Inspection method | Instrument | Record |
|----------------|--------------|--|-----|--|---------------------------------|---------------------------|-------------------|-----------------------|----------------------|
| | rystal l | | 1 | Inspecting section. | Purchasing specification | Size. | Sampling. | Measure. | In-coming inspection |
| | ∇ | | | (Ina / Miyazaki Plant) | Incoming inspection standard | Outer appearance. | " | Visual inspection. | data sheet. |
| | | | | • | - ' | Inner appearance. | " | Visual inspection. | |
| | (<u>1</u>) | In-coming inspection | 1' | Inspecting section. | " | | Sampling. | Comparator. | 11 |
| | Ŧ | 0 1 | | (Ina / Thailand / Malaysia Plant) | | Outer appearance. | " | Micro scope. | |
| | (2) | Wafer cutting | 2 | Inspecting section. | Manufacturing instruction sheet | Cut angle. | Sampling. | X-ray raido grafic. | Process data sheet. |
| | Ĩ | ŭ | | (Ina / Miyazaki Plant) | | Wafer thickness. | " | Comparator. | |
| Ceramic base | (3) | Wafer lapping | 3 | Producing section. | " | Frequency. | Sampling. | Frequency counter. | " |
| 1'> In-coming | | 11 0 | | (Ina / Miyazaki Plant) | | Wafer thickness. | " | Comparator. | |
| inspection | (4) | Photo process | 4 | Producing section. | " | Size. | Sampling. | Comparator. | " |
| | Ĭ | | | (Ina / Miyazaki Plant) | | Frequency. | " | Frequency counter. | |
| | | | | ,,, , | | Outer appearance. | " | Micro scope. | |
| Lid | 5 | Mounting | 5 | Producing section. | " | Outer appearance. | All insprcion. | Micro scope. | 11 |
| ∇ | Ĭ | | | (Ina / Thailand / Malaysia Plant / GKL) | | | | | |
| In-coming | 6 | Frequency adjustment | 6 | Producing section. | " | Frequency. | Sampling. | Network analyzer. | 11 |
| 1'> inspection | Ĭ | . roquerity adjustinoni | | (Ina / Thailand / Malaysia Plant / GKL) | | . roquonoj. | Camping. | | |
| | _ | | 7 | Producing section. | " | Outer appearance. | Sampling. | Micro scope. | 11 |
| | (7) | Welding | | (Ina / Thailand / Malaysia Plant / GKL) | | outer appearance. | Camping. | imoro ocopo. | |
| | Ĭ | | 8 | Producing section. | " | Airtightness check. | All insprcion. | Leak tester. | 11 |
| | (3) | Leak test | | (Ina / Thailand / Malaysia Plant / GKL) | | , anagranoso onosia | ,op. o.o | | |
| | | 20011 1001 | 9 | Producing section. | " | Outer appearance. | Sampling. | Micro scope. | 11 |
| | 9 | Marking | Ĭ | (Ina / Thailand / Malaysia Plant / GKL) | | с ию арроилинос. | Camping. | imoro ocopo. | |
| | Ĭ | ······································ | 10 | Producing section. | " | Crystal impedance. | All insprcion. | Inspectional machine. | " |
| | 60 3 | Characteristic inspection | . • | (Ina / Thailand / Malaysia Plant / GKL) | | Frequency. | // | // | |
| | Ÿ | onaractorione inspection | | (mar manarar manayota i tantr one) | | Insulation resistance. | ,, | " | |
| | | | | | | Temp. characteristic. | Sampling. | " | |
| | | | | | | Tomp. ondraotonotio. | Camping. | | |
| | 内 | Out-going inspection | 11 | Inspecting section. | Out-going inspection standard | Crystal impedance. | Sampling. | Inspection M/C. | Out-going inspection |
| | Y | gogopoolion | • • | (Ina / Thailand / Malaysia Plant / GKL) | gogopcollon olandard | Frequency. | II | III OPECUION IVII C. | data sheet. |
| | | | | (| | Insulation resistance. | " | " | 22.2 011000 |
| | | | | | | Outer appearance. | " | Micro scope. | |
| | (12) | Taping | 12 | Producing section. | Manufacturing instruction sheet | Tape-peel strength. | Sampling. | | Process data sheet. |
| | <u>.</u> | . ~PA | '- | (Ina / Thailand / Malaysia Plant / GKL) | | . apo poor onorigin. | Camping. | . 30 10100 100101. | |
| | (13) | Packing | 13 | Product control section. | Manufacturing instruction sheet | Address. | | | Delivery slip. |
| | ••• | i doming | ' | (Ina / Thailand / Malaysia Plant) | Packing instruction sheet | Quantity. | _ | _ | Donvory onp. |
| | | | | That manara manayola mant j | a doming mondout officer | edunity. | | | |
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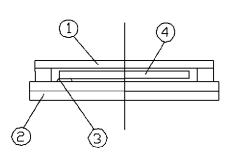
FA-128 Construction Drawing

No.: A-0502-AE-1









| No | Parts NAME | Material | Surface Treatment |
|------------|--------------|--------------------|--------------------------|
| ① | LII) | Covar | Ni Plating |
| 2 | BASE | Ceramic • Covar | Au Plating |
| (3) | Ag Paste | Bonding Paste of | |
| | | Electric Conductor | |
| (4) | Crystal Chip | Crystal | Electrode Pattern(Cr+Λu) |

RELIABILITY TEST DATA

Product Name: FA-128

The Company evaluation condition

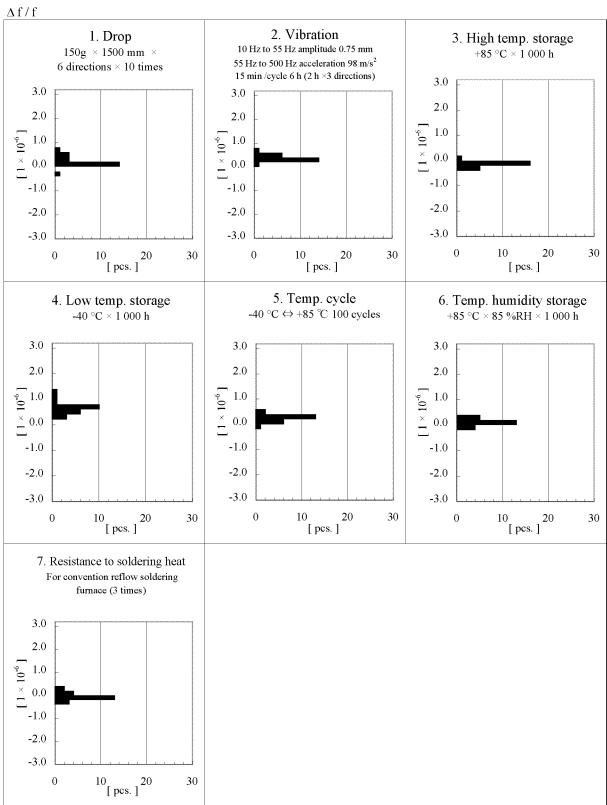
We evaluate environmental and mechanical characteristics by the following test condition.

| | | and meenamear characteristics by the following | VALUE *1 *2 | TEST | FAIL |
|-----|------------------------------|---|--|-------|-------|
| No. | ITEM | TEST CONDITIONS | Δf/f | Qty | Qty |
| | | | $[1 \times 10^{-6}]$ | [n] | [n] |
| 1 | Drop | 150 g dummy Jig (Epsontoyocom Standard) drop from 1500 mm height on the Concrete 6 directions 10 times | ± 2 | 22 | 0 |
| 2 | Vibration | 10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min / cycle 6 h (2 h × 3 directions) | ± 2 | 22 | 0 |
| 3 | High temperature storage | +85 °C × 1 000 h | ± 2 | 22 | 0 |
| 4 | Low temperature storage | -40 °C × 1 000 h | ± 2 | 22 | 0 |
| 5 | Temperature cycle | -40 °C ⇔ + 85 °C 30 min at each temp. 100 cycles | ± 2 | 22 | 0 |
| 6 | Temperature humidity storage | +85 °C × 85 %RH × 1 000 h | ± 2 | 22 | 0 |
| 7 | Resistance to soldering heat | For convention reflow soldering furnace (3 times) | ± 2 | 22 | 0 |
| 8 | Substrate bending | Bend width reaches 3.0 mm and hold for $5 \text{ s} \pm 1 \text{ s} \times 1 \text{ time}$ Ref. IEC 60068-2-21 | No peeling - off at a solder part | 11 | 0 |
| 9 | Shear | 10 N press for 10 s ± 1 s Ref. IEC 60068-2-21 | No peeling - off at a solder part | 11 | 0 |
| 10 | Pull - off | 10 N press for 10 s ± 1 s Ref. IEC 60068-2-21 | No peeling - off at a solder part | 11 | 0 |
| 11 | Solderability | Dip termination into solder bath at +235°C ± 10 °C for 5 s (Using Rosin Flux) | Termination must be 95 % covered with fresh solder | 11 | 0 |

Notes

- 1. *1 Each test done independently.
- 2. *2 Measuring 2 h to 24 h later leaving in room temperature after each test.
- 3. *3 Measuring 24 h later leaving in room temperature after each test.
 - 1. Reflow 3 times
 - 2. Initial value shall be after 24h at room temperature.
- 4. Shift series resistance at before above tests should be less than ± 20 % or less than ± 10 Ω .

Product Name: FA-128



Product Name: FA-128

